

# BLF183XR; BLF183XRS

Power LDMOS transistor

Rev. 1 — 19 August 2014

Objective data sheet

## 1. Product profile

### 1.1 General description

A 350 W extremely rugged LDMOS power transistor for broadcast and industrial applications in the HF to 600 MHz band.

Table 1. Application information

Test signal	f (MHz)	V <sub>DS</sub> (V)	P <sub>L</sub> (W)	G <sub>p</sub> (dB)	η <sub>D</sub> (%)
pulsed RF	108	50	350	25	75

### 1.2 Features and benefits

- Easy power control
- Integrated ESD protection
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (HF to 600 MHz)
- Compliant to Directive 2002/95/EC, regarding Restriction of Hazardous Substances (RoHS)

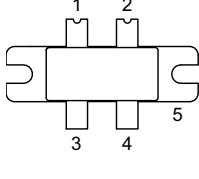
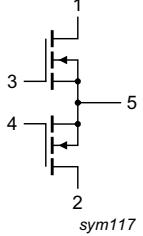
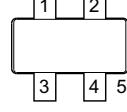
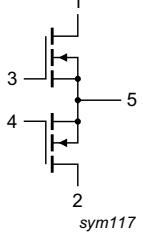
### 1.3 Applications

- Industrial, scientific and medical applications
- Broadcast transmitter applications



## 2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
<b>BLF183XR (SOT1121A)</b>			
1	drain1		
2	drain2		
3	gate1		
4	gate2		
5	source	[1]	 
<b>BLF183XRS (SOT1121B)</b>			
1	drain1		
2	drain2		
3	gate1		
4	gate2		
5	source	[1]	 

[1] Connected to flange.

## 3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BLF183XR	-	flanged LDMOST ceramic package; 2 mounting holes; 4 leads	SOT1121A
BLF183XRS	-	earless flanged ceramic package; 4 leads	SOT1121B

## 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	135	V
$V_{GS}$	gate-source voltage		-6	+11	V
$T_{stg}$	storage temperature		-65	+150	°C
$T_j$	junction temperature	[1]	-	225	°C

[1] Continuous use at maximum temperature will affect the reliability, for details refer to the on-line MTF calculator.

## 5. Thermal characteristics

**Table 5. Thermal characteristics**

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-c)}$	thermal resistance from junction to case	$T_j = 150 \text{ }^\circ\text{C}$ [1][2]	<tbd>	K/W
$Z_{th(j-c)}$	transient thermal impedance from junction to case	$T_j = 150 \text{ }^\circ\text{C}; t_p = 100 \mu\text{s}; \delta = 20 \%$ [3]	<tbd>	K/W

[1]  $T_j$  is the junction temperature.

[2]  $R_{th(j-c)}$  is measured under RF conditions.

[3] See <tbd>.

## 6. Characteristics

**Table 6. DC characteristics**

$T_j = 25 \text{ }^\circ\text{C}$ ; per section unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 1.5 \text{ mA}$	135	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$V_{DS} = 10 \text{ V}; I_D = 150 \text{ mA}$	1.25	1.8	2.25	V
$V_{GSq}$	gate-source quiescent voltage	$V_{DS} = 50 \text{ V}; I_D = 50 \text{ mA}$	-	1.6	-	V
$I_{DSS}$	drain leakage current	$V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}$	-	-	1.4	$\mu\text{A}$
$I_{DSX}$	drain cut-off current	$V_{GS} = V_{GS(th)} + 3.75 \text{ V}; V_{DS} = 10 \text{ V}$	-	21	-	A
$I_{GSS}$	gate leakage current	$V_{GS} = 11 \text{ V}; V_{DS} = 0 \text{ V}$	-	-	140	nA
$R_{DS(on)}$	drain-source on-state resistance	$V_{GS} = V_{GS(th)} + 3.75 \text{ V}; I_D = 9.625 \text{ A}$	-	0.29	-	$\Omega$

**Table 7. AC characteristics**

$T_j = 25 \text{ }^\circ\text{C}$ ; per section unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$C_{rs}$	feedback capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}; f = 1 \text{ MHz}$	-	1.1	-	pF
$C_{iss}$	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}; f = 1 \text{ MHz}$	-	156	-	pF
$C_{oss}$	output capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}; f = 1 \text{ MHz}$	-	80	-	pF

**Table 8. RF characteristics**

Test signal: pulsed RF;  $t_p = 100 \mu\text{s}; \delta = 20 \%; f = 108 \text{ MHz}$ ; RF performance at  $V_{DS} = 50 \text{ V}$ ;  $I_{DQ} = 100 \text{ mA}$ ;  $T_{case} = 25 \text{ }^\circ\text{C}$ ; unless otherwise specified; in a class-AB production test circuit.

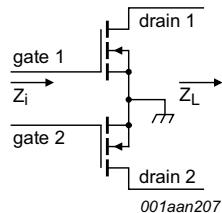
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$G_p$	power gain	$P_L = 350 \text{ W}$	<tbd>	25	-	dB
$RL_{in}$	input return loss	$P_L = 350 \text{ W}$	-	<tbd>	-	dB
$\eta_D$	drain efficiency	$P_L = 350 \text{ W}$	<tbd>	75	-	%

## 7. Test information

### 7.1 Ruggedness in class-AB operation

The BLF183XR and BLF183XRS are capable of withstanding a load mismatch corresponding to VSWR > 65 : 1 through all phases under the following conditions:  
 $V_{DS} = 50$  V;  $I_{Dq} = 100$  mA;  $P_L = 350$  W pulsed;  $f = 108$  MHz.

### 7.2 Impedance information



**Fig 1. Definition of transistor impedance**

**Table 9. Typical push-pull impedance**

Simulated  $Z_i$  and  $Z_L$  device impedance; impedance info at  $V_{DS} = 50$  V and  $P_L = 350$  W.

<b>f</b> <b>(MHz)</b>	<b><math>Z_i</math></b> <b>(<math>\Omega</math>)</b>	<b><math>Z_L</math></b> <b>(<math>\Omega</math>)</b>
108	<tbd>	<tbd>

### 7.3 UIS avalanche energy

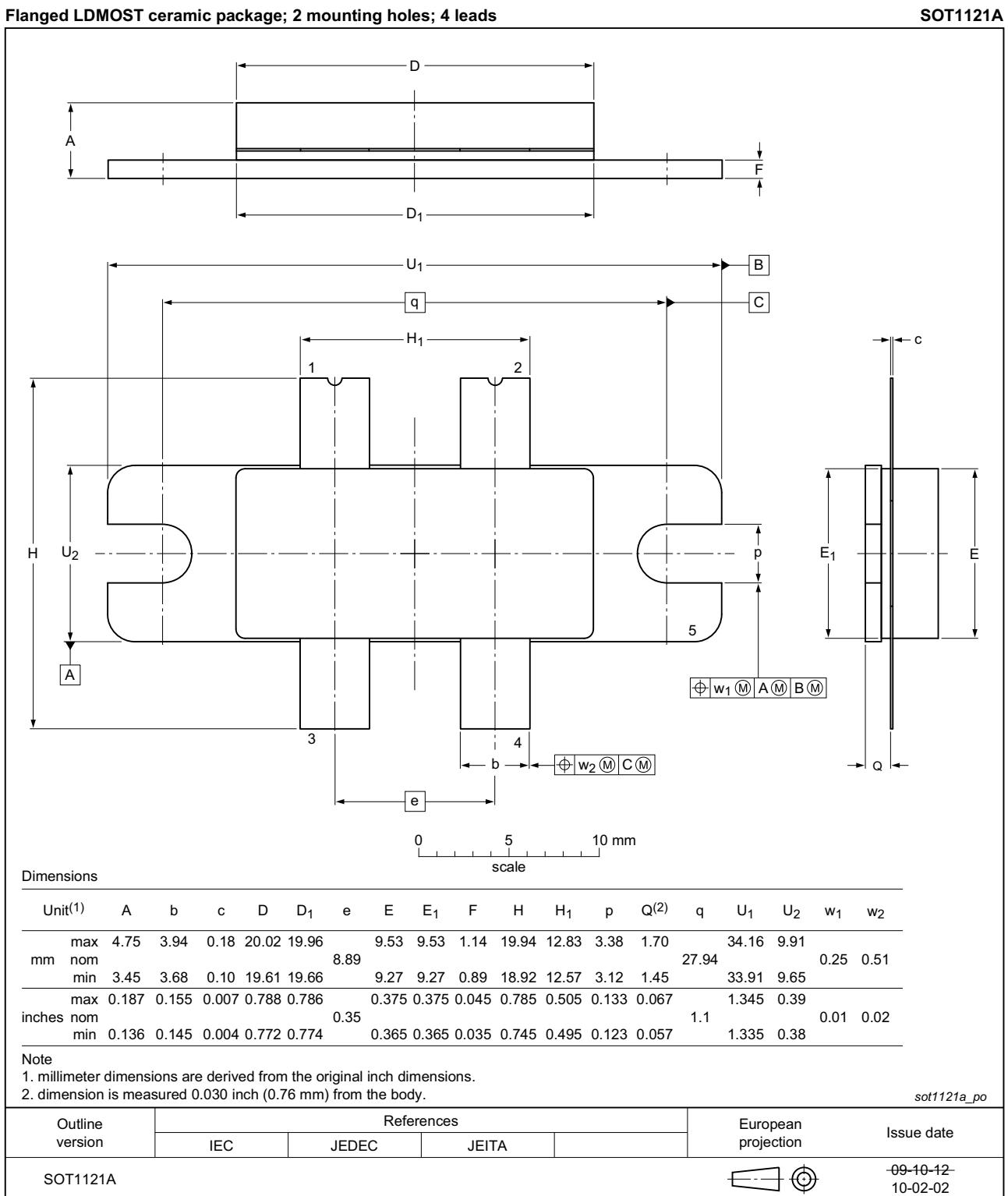
**Table 10. Typical avalanche data per section**

$T_{amb} = 25$  °C; typical test data; test jig without water cooling.

<b><math>I_{AS}</math></b> <b>(A)</b>	<b><math>E_{AS}</math></b> <b>(J)</b>
<tbd>	<tbd>
<tbd>	<tbd>
<tbd>	<tbd>

For information see application note AN10273.

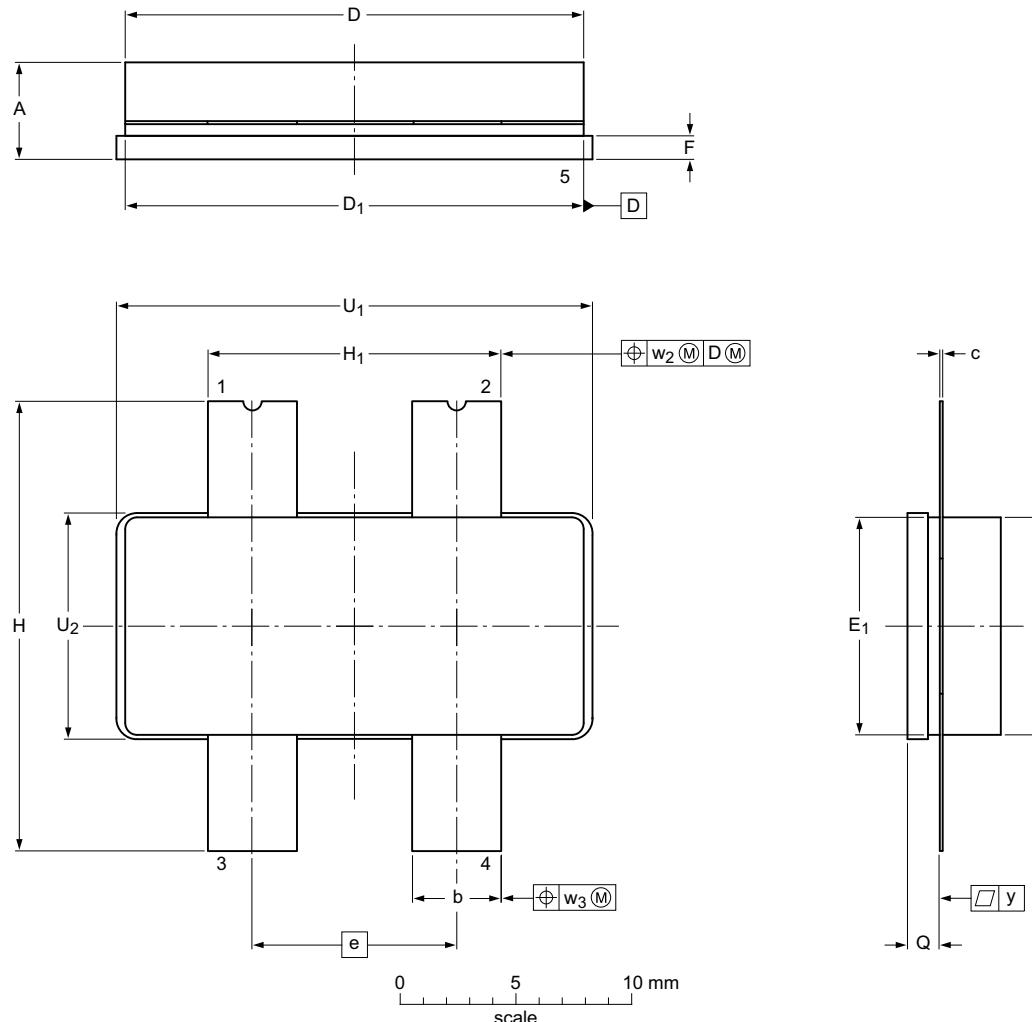
## 8. Package outline



**Fig 2. Package outline SOT1121A**

## Earless flanged ceramic package; 4 leads

SOT1121B



## Dimensions

Unit <sup>(1)</sup>	A	b	c	D	D <sub>1</sub>	e	E	E <sub>1</sub>	F	H	H <sub>1</sub>	Q	U <sub>1</sub>	U <sub>2</sub>	w <sub>2</sub>	w <sub>3</sub>	y
mm	max 4.75	3.94	0.18	20.02	19.96		9.53	9.53	1.14	19.94	12.83	1.70	20.70	9.91	0.51	0.25	0.25
mm	nom					8.89											
mm	min 3.45	3.68	0.08	19.61	19.66		9.27	9.27	0.89	18.92	12.57	1.45	20.45	9.65			
inches	max 0.187	0.155	0.007	0.788	0.786		0.375	0.375	0.045	0.785	0.505	0.067	0.815	0.39	0.02	0.01	0.01
inches	nom					0.35											
inches	min 0.136	0.145	0.003	0.772	0.774		0.365	0.365	0.035	0.745	0.495	0.057	0.805	0.38			

## Note

1. millimeter dimensions are derived from the original inch dimensions.
2. dimension is measured 0.030 inch (0.76 mm) from the body.

sot1121b\_po

Outline version	References				European projection	Issue date
	IEC	JEDEC	JEITA			
SOT1121B						09-12-14 12-06-07

Fig 3. Package outline SOT1121B

## 9. Handling information

**CAUTION**

This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

## 10. Abbreviations

**Table 11. Abbreviations**

Acronym	Description
CW	Continuous Wave
ESD	ElectroStatic Discharge
HF	High Frequency
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor
MTF	Median Time to Failure
UIS	Unclamped Inductive Switching
VSWR	Voltage Standing-Wave Ratio

## 11. Revision history

**Table 12. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLF183XR_BLF183XRS v.1	20140819	Objective data sheet	-	-

## 12. Legal information

### 12.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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